

650V Super Junction Power MOSFET

Features:

- ◇ High Speed Power Switching
- ◇ 100% UIS Tested, 100% Rg Tested
- ◇ Enhanced Avalanche Ruggedness
- ◇ Lead Free, Halogen Free

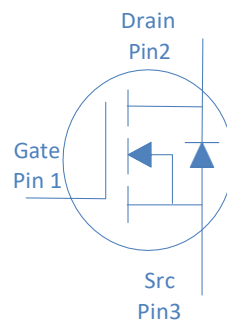
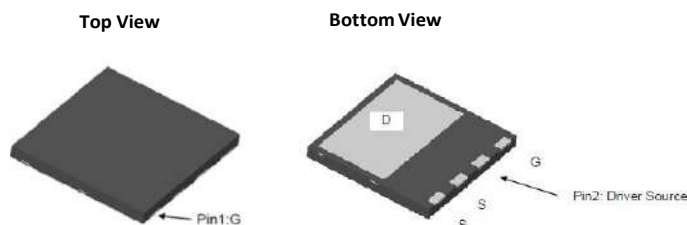
Application :

- ◇ SMPS
- ◇ Hard Switching and High Speed Circuit
- ◇ LED Lighting
- ◇ Flyback

V_{DS}	650	V
$R_{DS(on),max}$	235	mΩ
I_D	17	A

Part Number	Package	Marking
KWSC65R235Y	DFN8*8	SC65R235Y

DFN8*8



Absolute Maximum Ratings at $T_J=25^\circ\text{C}$ (unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	17	A
Drain to Source Voltage	V_{DS}	-	650	V
Gate to Source Voltage	V_{GS}	-	± 30	V
Pulsed Drain Current	I_{DM}	-	64	A
Avalanche Energy, Single Pulse	E_{AS}	$T_C=25^\circ\text{C}$	505	mJ
Power Dissipation	P_D	$T_C=25^\circ\text{C}$	278	W
Operating and Storage Temperature	T_J, T_{stg}	-	-55 to 150	$^\circ\text{C}$

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Case	R_{thJC}	0.45	$^\circ\text{C/W}$
Thermal Resistance Junction-Ambient	R_{thJA}	50	$^\circ\text{C/W}$

Electrical Characteristics at $T_j=25^{\circ}\text{C}$ (unless otherwise specified)

Static Characteristics

Parameter	Symbol	Conditions	Value			Unit
			min	typ	max	
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	650	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2.4	3.4	4.4	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS}=0V, V_{DS}=650V, T_j=25^{\circ}\text{C}$	-	-	1	μA
Gate to Source Leakage Current	I_{GSSF}	$V_{GS}=30V, V_{DS}=0V$	-	-	100	nA
	I_{GSSR}	$V_{GS}=-30V, V_{DS}=0V$	-	-	-1	μA
Drain to Source on Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=8A$	-	196	235.2	m Ω
Gate Resistance	R_G	$V_{GS}=0V, V_{DS}$ Open, $f=1\text{MHz}$	-	1.7	-	Ω

Dynamic Characteristics

Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=50V, f=1\text{MHz}$	-	1630	-	pF
Output Capacitance	C_{oss}		-	110	-	
Reverse Transfer Capacitance	C_{rss}		-	22.0	-	
Effective output capacitance, energy related	$C_{O(er)}$	$V_{GS}=0V, V_{DS}=0\ldots 480V$	-	71	-	pF
Effective output capacitance, time related	$C_{O(tr)}$		-	301	-	
Total Gate Charge	Q_g	$V_{DD}=480V, I_D=10A, V_{GS}=10V$	-	38.0	-	nC
Gate to Source Charge	Q_{gs}		-	10.6	-	
Gate to Drain (Miller) Charge	Q_{gd}		-	12.2	-	
Turn on Delay Time	$t_{d(on)}$	$V_{DD}=400V, I_D=10A, V_{GS}=10V, R_G=3.4\Omega,$	-	11	-	ns
Rise time	t_r		-	10	-	
Turn off Delay Time	$t_{d(off)}$		-	76	-	
Fall Time	t_f		-	8	-	

Reverse Diode Characteristics

Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_F=10A$	-	0.83	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=400V, I_F=10A, dI_F/dt=100A/\mu s$	-	330	-	ns
Reverse Recovery Charge	Q_{rr}		-	4.5	-	μC
Reverse Recovery Charge	I_{rm}		-	27.0	-	μC

Fig 1. Typical Output Characteristics

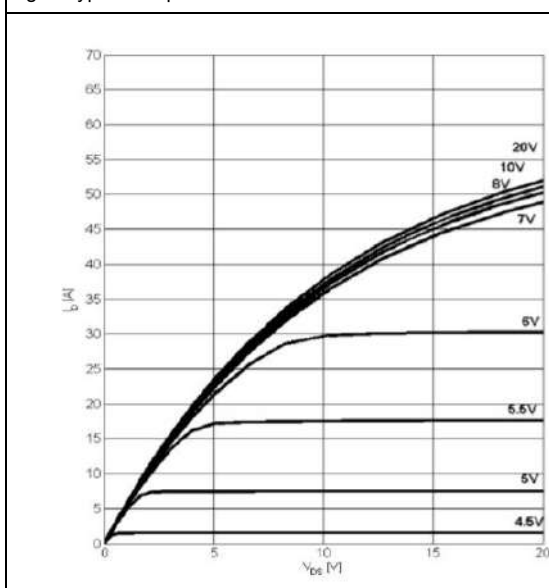


Figure 2. Typical Output Characteristics 125°C

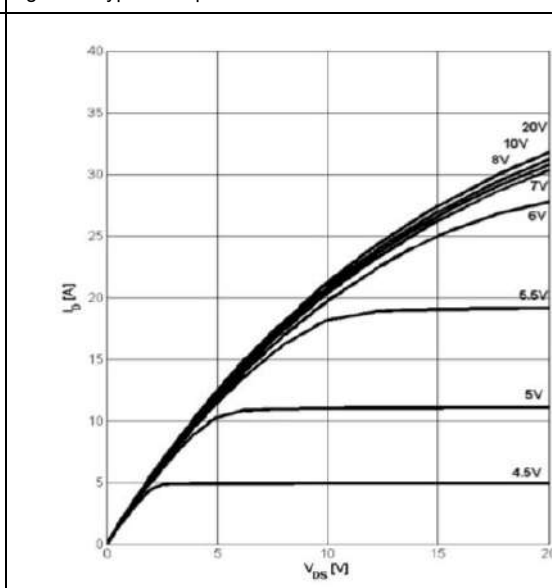


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

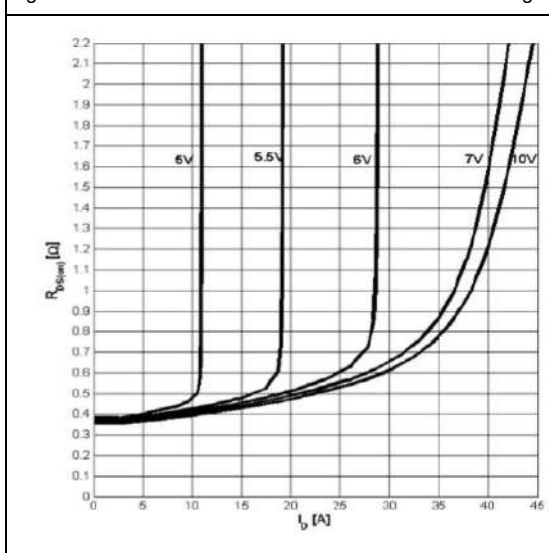


Figure 4. On-Resistance Variation vs. Junction Temperature

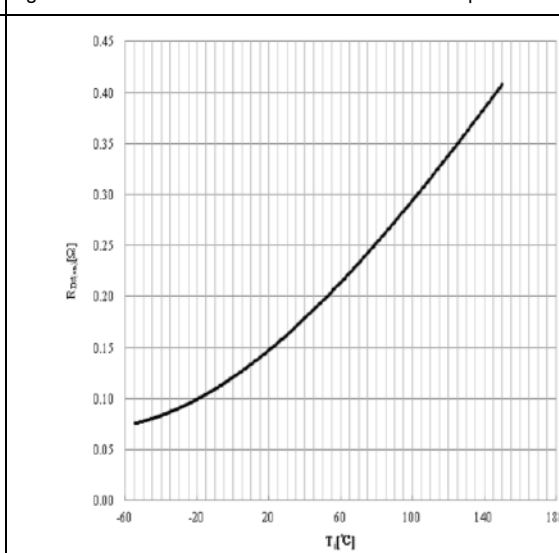


Figure 5. Typical Transfer Characteristics

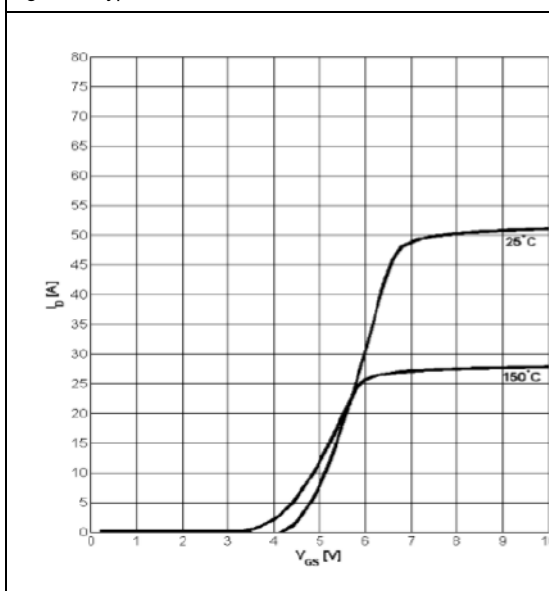


Figure 6: Typical Source-Drain Diode Forward Voltage

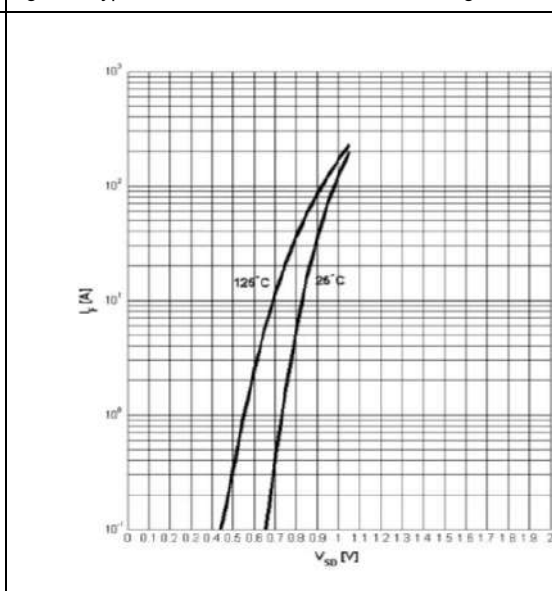


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

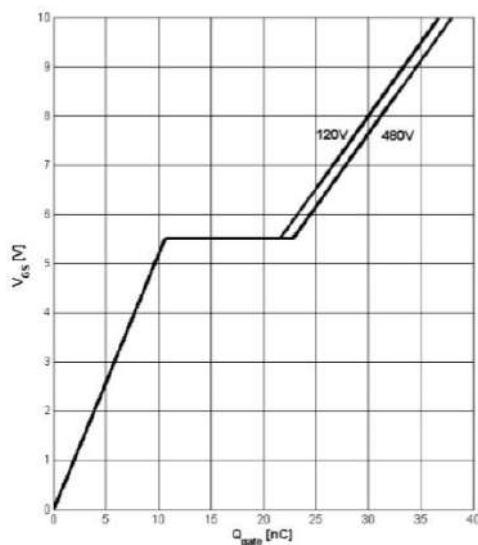


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

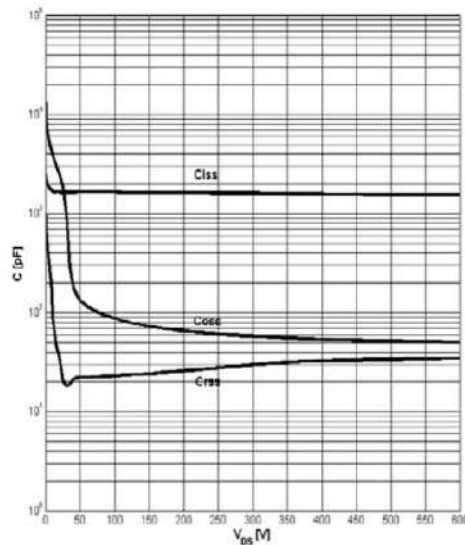


Figure 9. Maximum Safe Operating Area

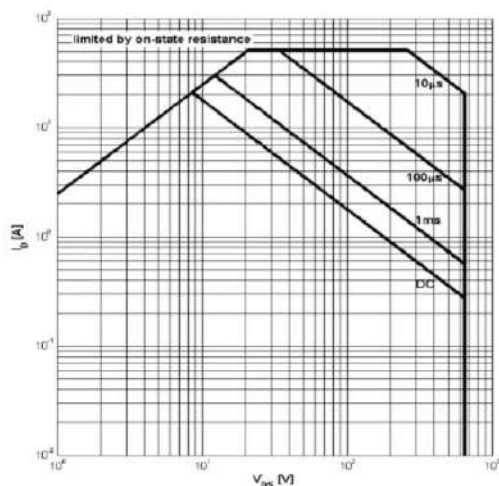


Figure 10. Power Dissipation

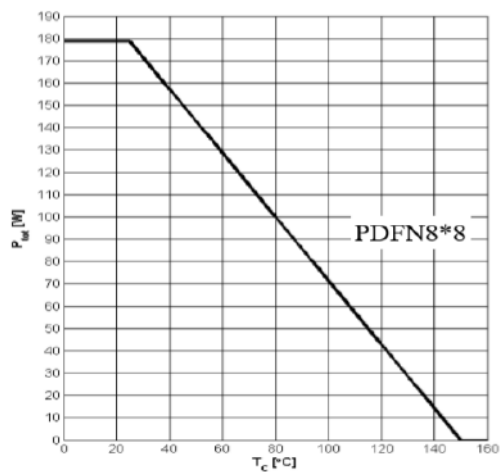


Figure 11. Normalized BV vs temperature

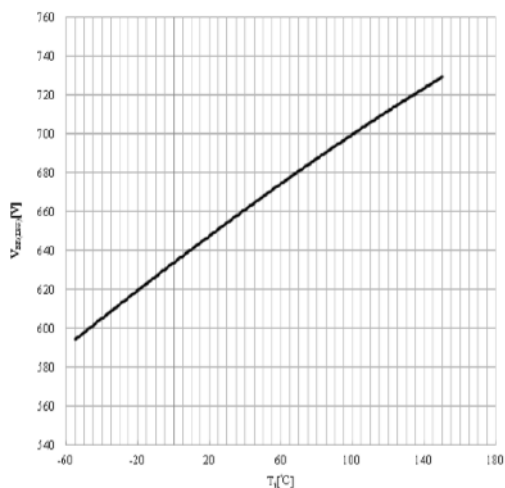
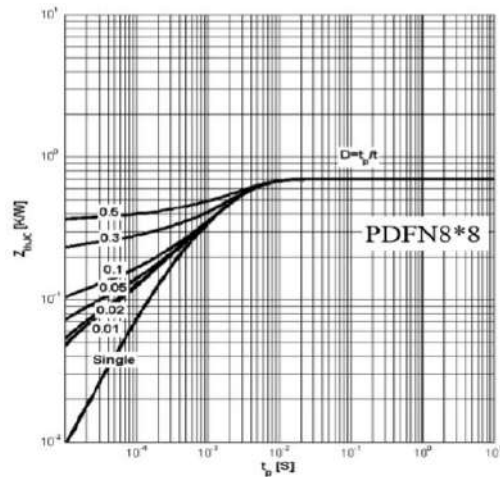
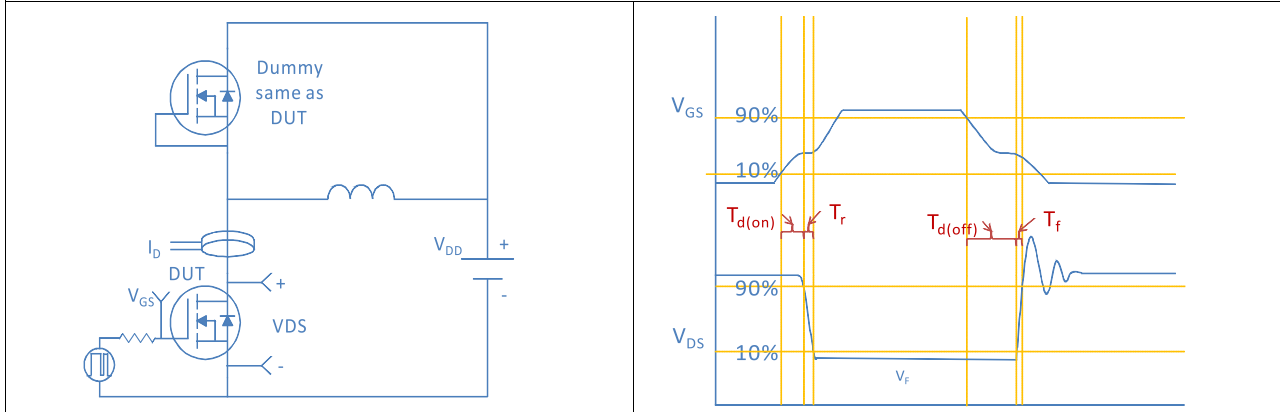


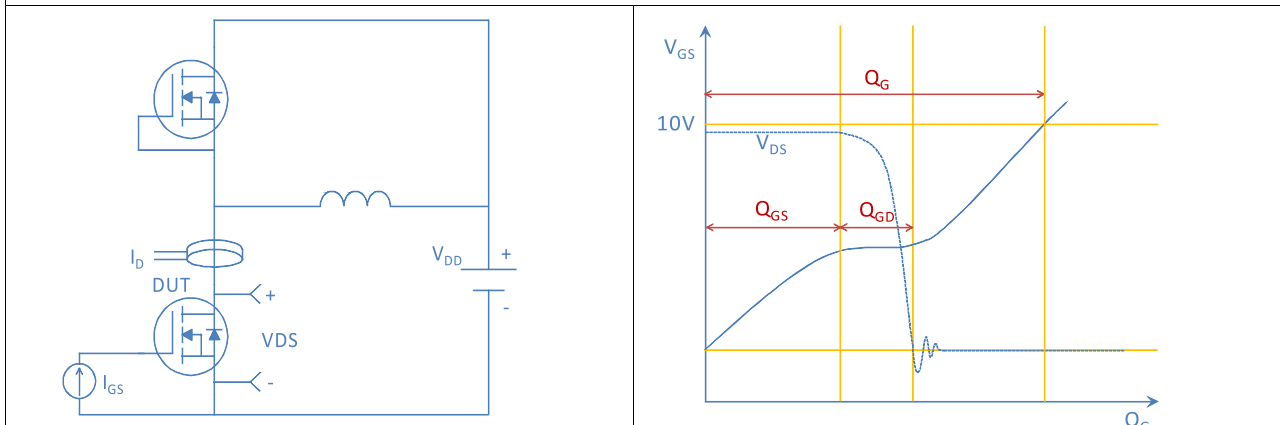
Figure 12. Normalized Maximum Transient Thermal Impedance, Junction-to-Case



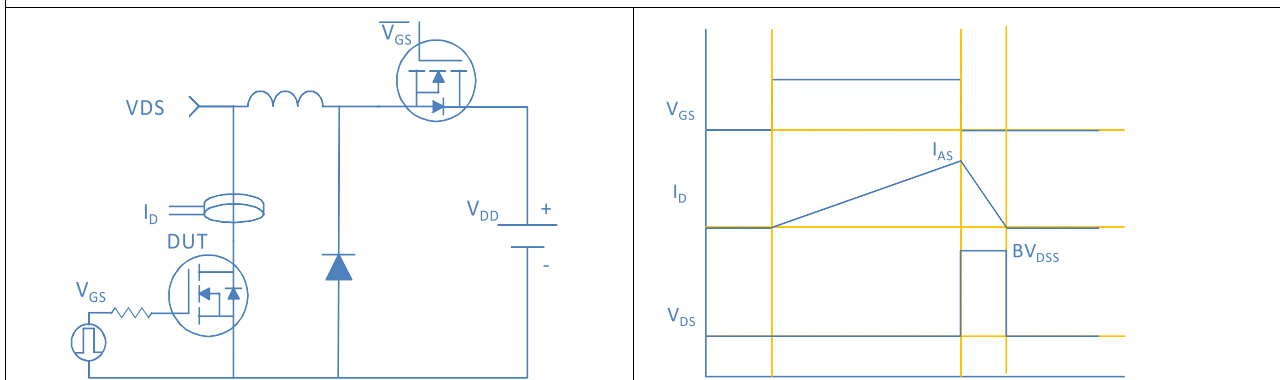
Inductive switching Test



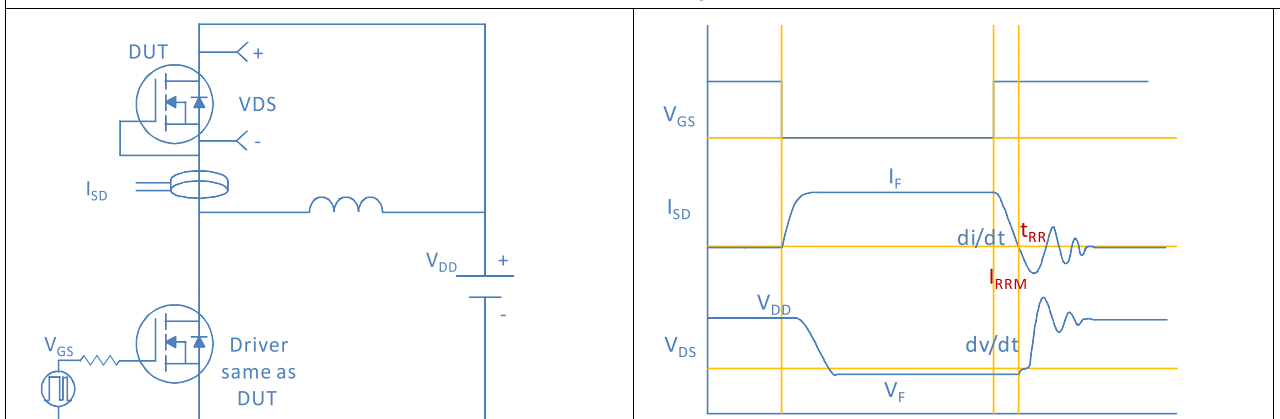
Gate Charge Test



Uclamped Inductive Switching (UIS) Test

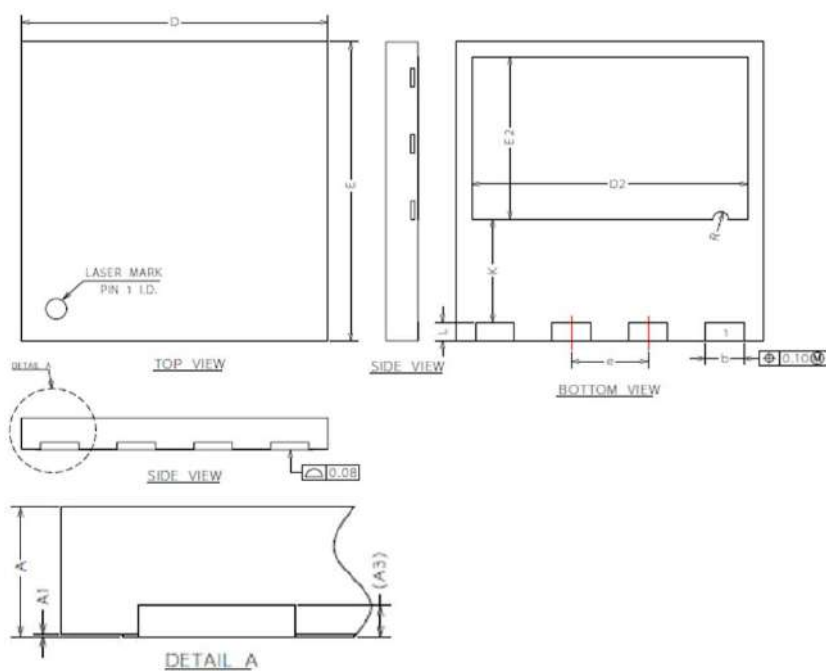


Diode Recovery Test



Package Outline

DFN8*8



Symbol	Dimensions(mm)		
	Min.	Typ.	Max.
A	0.80	0.85	0.90
A1	0.00	0.02	0.05
A3	0.20REF		
b	0.90	1.00	1.10
D	7.90	8.00	8.10
D2	7.10	7.20	7.30
E	7.90	8.00	8.10
E2	4.25	4.35	4.45
e	2.00(BSC)		
K	2.65	2.75	2.85
L	0.40	0.50	0.60
R	0.20REF		